

Notice of References Cited

Application/Control No.

10/563,126

Applicant(s)/Patent Under

Reexamination

TAKAHASHI ET AL.

Examiner

ROBERT HODGE

Art Unit

1795

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,030,528	07-1991	Shen et al.	429/330
	B	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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